

Search Notes**Application/Control No.**

10/770,471

Examiner

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Applicant(s)/Patent under Reexamination

SHIN ET AL.

Art Unit

2815

SEARCHED

Class	Subclass	Date	Examiner
257	295	3/22/2006	AW
257	E27.048	3/22/2006	AW
257	E27.104	3/22/2006	AW
257	E29.164	3/22/2006	AW
257	E29.272	3/22/2006	AW
257	E29.342-3	3/22/2006	AW
257	E21.208	3/22/2006	AW
257	E21.663-4	3/22/2006	AW
438	3	3/22/2006	AW
365	145	3/22/2006	AW
501	134	3/22/2006	AW
257	E27.084	3/22/2006	AW

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
257	see above	3/22/2006	AW
438	3	3/22/2006	AW
365	145	3/22/2006	AW
501/134		3/22/2006	AW

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	3/22/2006	AW
IEEE Xplore	3/22/2006	AW
Dialog DataStar	3/22/2006	AW